A Data-Driven Fault Location Algorithm Based on the Electromagnetic Time Reversal in Mismatched Media

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Abstract—The classical electromagnetic time reversal (EMTR) fault location method in power systems requires multiple simulations in the backward step, assuming different guessed fault locations along the line. This process can be time consuming especially when a high location accuracy is desired, as it may require a significant number of guessed fault locations. To cope with this issue, the concept of EMTR in mismatched media has recently been introduced, allowing reducing the backward simulations to a single run and, thus, substantially improving the computation efficiency of the EMTR-based fault location technique. In this paper, we present a detailed study of the mismatched-media-based mirrored minimum energy property. This property has been applied in a few recent studies but never been theoretically studied and rigorously demonstrated. First, we infer a transfer function that relates the fault source to the voltage along the line resulting from back-injecting the time-reversed transients measured at a given observation point. We present a theorem according to which, at the fault switching frequency and its odd harmonics, the mirrorimage point of the fault location with respect to the line center corresponds to a local minimum of the squared modulus of the transfer function. Then, it is proved that the mirrored minimum energy property is a corollary of this theorem. Based on these theoretical findings, we propose an algorithm that utilizes the reversed-time voltage energy as a fault location metric in the frequency domain. We further advance a data-driven strategy to maximize the computation efficiency of the fault location procedure. The applicability and robustness of the proposed frequencydomain fault location metric are numerically and experimentally validated.

Index Terms—Data-driven methods, electromagnetic time reversal, fault location, mismatched media, power systems, transmission lines.

I. INTRODUCTION

ONSIDERABLE research effort has been devoted to the problem of fault location in power networks [1]–[3]. As a result, various techniques have been proposed, which can be classified into two main categories: *i*) impedance- (or phasor-) based methods (e.g., [4]–[10]), and *ii*) traveling-wave- (or high-frequency-component-) based methods (e.g., [11]–[19]). In addition, the latest studies reflect a tendency to combine these traditional methods with artificial intelligence techniques (e.g., [20]–[24]). In the past decade, the *electromagnetic time*

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reversal (EMTR) has been considered a promising alternative to the traditional fault location methods by taking advantage of the *time-reversal invariance* of wave equations (e.g., [25]–[29]).

The EMTR-based fault location method belongs to the traveling-wave-based category as it relies on the measurement of post-fault transient traveling waves. This category of methods is generally less sensitive to fault diversity (e.g., fault type and impedance) and less influenced by power-frequency injections of dispersed energy resources [1]. Meanwhile, in virtue of the time-reversal inherent property of refocusing time-reversed waves (e.g., fault-originated transients) to the original and unknown source, the EMTR-based method possesses a number of advantages with respect to classical traveling-wave-based methods. First, a single-end measurement suffices to locate faults as power networks behave as a closed reflective propagation medium [28]. The measurement can be carried out using either voltage transducers (e.g., resistive-capacitive voltage dividers [30]) or current probes (e.g., industrial Rogowski coils [31]) to acquire fault-induced traveling waves (either voltage or current) at the outgoing side of a substation. Secondly, it is equally applicable to power transmission and distribution systems [32]–[35]. Lastly, classical traveling-wave methods, which depend on either feature extraction or wavefront arrival time detection, generally utilize dedicated signal processing approaches, such as wavelet analysis, classification techniques as well as machine learning (e.g., [13], [22], [36]-[38]). The EMTR method applies the time-reversal operation to the full waveform of the measured transients and, if needed, the timefrequency transform (required by some of the frequency-domain metrics). In this way, the implementation of the EMTR method is characterized by a low level of complexity.

In brief, the implementation of the EMTR method is carried out through a two-step process. For the sake of illustration, let us consider a fault event along a single-wire line. Fig. 1a schematically depicts the forward propagation step (or the *direct time*), in which a fault occurs at $x=x_f$. The fault transient voltage $V_0^{\rm DT}(t)$ is measured at one line end (e.g., x=0). The second step, named the backward propagation step (or the *reversed time*), consists of numerically simulating the back-injection of the time-reversed high-frequency transients $V_0^{\rm TR}(t)$ from the observation point into the line, as illustrated in Fig. 1b [28].

One of the fundamental hypotheses of time reversal is that the propagation media in the forward and backward steps are identical, a condition being referred to as *matched media* [39],

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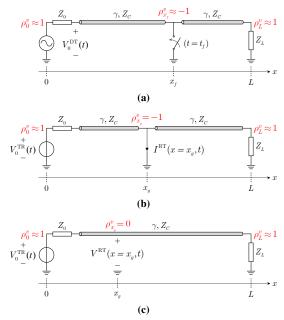


Fig. 1: Schematic representation of (a) a fault occurrence along transmission lines and the application of EMTR to locate the fault based on the conditions of: (b) matched media and (c) mismatched media. $\rho_0^v(\rho_L^v)$, $\rho_{x_f}^v$, and $\rho_{x_g}^v$ are the voltage reflection coefficients at the line terminal x=0(L), the fault location $x=x_f$, and the guessed fault location $x=x_g$, respectively. $Z_0(Z_L)$ is the input impedance of terminal power equipment.

[40]. With regard to the fault location problem, the propagation medium in the fault occurrence stage can be described by two main sets of parameters: i) the line *physical characteristics*, namely its length L, characteristic impedance Z_C and propagation constant γ , and ii) the *boundary conditions* at the line terminals and at the fault location.

The boundary conditions are generally described using voltage and/or current reflection coefficients [41]. Supposed being connected to power transformers, the line terminals constitute, to a first approximation, open circuits from the viewpoint of the frequency contents of fault-associated transients [42]. As a result, the terminal voltage reflection coefficient reads [41]

$$\rho_0^v(\rho_L^v) = \frac{Z_0(Z_L) - Z_C}{Z_0(Z_L) + Z_C} \approx +1. \tag{1}$$

Conversely, the voltage reflection coefficient associated with the fault location, $\rho^v_{x_f}$, is close to -1 when a solid or low-impedance fault occurs. In the classical application of EMTR to fault location, a fault event is simulated in the backward step considering $\rho^v_{x_g} = -1$ (see Fig. 1b). In particular, the matched-media condition is satisfied when the guessed fault location x_g coincides with the original fault location.

Various metrics have been proposed to quantify the time-reversed transients refocusing at the original fault location (see Table I). Razzaghi *et al.* advanced in 2013 the metric of fault current signal energy that portrays the true fault location with the maximum energy concentration [32]. He *et al.* proposed the fault current signal peak amplitude as an alternative metric to deal with situations where fault-induced transients are limited by a low signal-to-noise ratio [43]. A theoretical study was then presented to infer the correlation between the transfer

TABLE I: EMTR-based fault location metrics

Matched-media-based metrics	
Fault current signal energy (FCSE)	[32]
Fault current signal amplitude peak (∞-norm)	[43]
Cross-correlation sequence (MCCS)	[34], [44]
Correlation estimator	[35]
Root mean square	[45]
Lumped-mismatched-media-based metri	cs
Phase angle range	[47]
Voltage signal energy	[48], [49]

functions formulated in the direct time and the reversed time, respectively [35]. Taking advantage of the similarity between the back-injected time-reversed transients and the fault current signal, a metric named the maximum of cross-correlation sequences was proposed in [34], [44]. The direct-time transfer function in [34] and [35] is defined as the ratio of fault-originated transients [denoted by $V_0^{\rm DT}(j\omega)$] to fault sources. The input and output of the reversed-time transfer function are the time-reversed copy of $V_0^{\rm DT}(j\omega)$ and its induced fault current observed at a guessed fault location, respectively. Besides, Zhang *et al.* introduced the so-called mirror lines, according to which the true fault location is identified by a set of root mean square (RMS) metrics, such as the RMS value of the fault current signal that is constructed by assuming the targeted line being lossless [45].

However, x_f being unknown before solving the fault location problem, the application of the foregoing metrics relies on first defining a set of *a priori* guessed fault locations (e.g., x_g in Fig. 1b) and then simulating a fault for each of these locations. When a high location accuracy is desired, the guessed fault locations need to be defined with a high density, calling for a heavy computation burden to simulate an increasing number of backward propagation cases.

Inspired by emerging studies of time-reversal in *mismatched* or *changing media* (e.g., [46]), the concept of *lumped mismatched media* was recently introduced to fault location [47], [48]. To be specific, we proposed to consider a fixed topology of a non-faulty power network in the backward step, excluding the transverse branch associated with the fault, as illustrated in Fig. 1c. This would produce a mismatch between the forward-and backward-propagation media as a result of modifying the boundary condition at the guessed fault location from the state of fault (i.e., $\rho_{x_g}^v = -1$) to that of non-fault (i.e., $\rho_{x_g}^v = 0$). This also constitutes a lumped mismatch in the sense that all the other line characteristics and the boundary conditions at the line extremities remain intact.

Note that such a modified backward-propagation medium does not require the independent simulation of the fault current $I^{\rm RT}(x,t)$ for each guessed fault location. More precisely, only a single simulation is needed to analyze the voltage $V^{\rm RT}(x,t)$ along the non-faulty line. In this respect, its frequency-domain counterpart $V^{\rm RT}(x,j\omega)$ is proved to hold a property named *bounded phase* allowing an effective identification of the fault location [47].

The proposed lumped mismatched media have been numerically shown to satisfy another property named *mirrored mini-*

$$V^{\text{RT}}(x,j\omega) \triangleq V(x,j\omega) = (1-\rho_0^v) \cdot \frac{e^{-\gamma \cdot x} + \rho_L^v \cdot e^{-\gamma \cdot (2L-x)}}{2\left[1-\rho_0^v \cdot \rho_L^v \cdot e^{-\gamma \cdot 2L}\right]} \cdot V_0^{\text{TR}}(j\omega). \tag{4}$$

$$\mathcal{H}(x,j\omega) = (1 - \rho_0^v) \cdot \frac{e^{-\gamma \cdot x} + \rho_L^v \cdot e^{-\gamma \cdot (2L - x)}}{2\left[1 - \rho_0^v \cdot \rho_L^v \cdot e^{-\gamma \cdot 2L}\right]} \cdot \left[(1 + \rho_0^v) \cdot \frac{e^{-\gamma \cdot x_f}}{1 + \rho_0^v \cdot e^{-\gamma \cdot 2x_f}} \right]^* . \tag{9}$$

$$|\mathcal{H}_{d}(x,j\omega)|^{2} = \overbrace{\left|1 + \rho_{L}^{v} \cdot e^{-\alpha \cdot 2(L-x)} \cdot e^{-j\beta \cdot 2(L-x)}\right|^{2} \cdot e^{-\alpha \cdot 2x}}^{|\mathcal{H}_{d}(x,j\omega)|^{2}} \cdot \underbrace{\frac{\left[1 - (\rho_{0}^{v})^{2}\right]^{2} \cdot e^{-\alpha \cdot 2x_{f}}}{4\left|1 - \rho_{0}^{v} \cdot \rho_{L}^{v} \cdot e^{-\alpha \cdot 2L} \cdot e^{-j\beta \cdot 2L}\right|^{2} \cdot \left|1 + \rho_{0}^{v} \cdot e^{-\alpha \cdot 2x_{f}} \cdot e^{j\beta \cdot 2x_{f}}\right|^{2}}}.$$
(11)

mum energy, according to which the energy of $V^{\rm RT}(x,t)$ is minimum at the mirror-image point of the fault location with respect to the line center [48]. Recently, An et al. suggested an extended algorithm applying the property with a particular focus on high-impedance fault location [49]. So far, the property itself has not been analyzed nor rigorously demonstrated. The main goal of this paper is to bridge this theoretical gap.

A thorough analysis and demonstration of this property are presented in Section II. Next, the frequency-domain calculation of the energy of $V^{\rm RT}(x,j\omega)$ as a fault location metric is proposed in Section III. The main peculiarity of the frequencydomain operation consists in collecting an array of normalized reversed-time transfer functions over a set of guessed fault locations and a range of frequencies of interest. Applying the concept of mismatched media to fault location allows reducing the simulation to a single run in the backward step. We demonstrate that it is possible to further improve the computational efficiency of the fault location procedure by leveraging a datadriven strategy, thereby advancing EMTR-based fault location towards a real-time implementation. In this regard, an acceleration algorithm is proposed in Section III. The validity and robustness of the frequency-domain metric, together with the computational efficiency of the proposed algorithm, are numerically studied in Sections III. The performance of the proposed metric is further compared in Section IV with respect to three representative traveling-wave-based metrics. Then, Section V reports an experimental validation of the proposed metric using a reduced-scale set-up. We present in Section VI a discussion about the present study, and Section VII concludes this paper with final remarks.

II. PROPERTIES OF THE DIRECT-REVERSED-TIME TRANSFER FUNCTION

As illustrated in Fig. 1, the fault location method of EMTR in lumped mismatched media is based on illustrating the respective propagation characteristics in the direct time and the reversed time. In this section, we analytically express the two stages' propagation characteristics in the frequency domain by formulating corresponding transfer functions. Specifically, the direct-time transfer function relates the fault event (i.e., the initial excitation $V_f(j\omega)$ [32], [34]) and its originated transients $V_0^{\rm DT}(j\omega)$. The reversed-time transfer function is the ratio of the voltage response $V^{\rm RT}(x,j\omega)$ to $V_0^{\rm DT}(j\omega)$ being time reversed and back injected as the secondary excitation. The direct-reversed-time transfer function is defined to combine the two stages' transfer functions and constitutes a measure to the focusing property in the mismatched-media condition.

i) The voltage observed in the direct time at the line end x = 0 in response to a fault occurrence at $x = x_f$:

$$V_0^{\mathrm{DT}}(j\omega) \triangleq V(x=0,j\omega) = \frac{(1+\rho_0^v) \cdot e^{-\gamma \cdot x_f}}{1+\rho_0^v \cdot e^{-\gamma \cdot 2x_f}} \cdot V_f(j\omega).$$
(2)

ii) The complex conjugate of $V_0^{\rm DT}(j\omega)$ corresponds to the time-reversed function $V_0^{\text{DT}}(-t)$:

$$V_0^{\mathrm{DT}}(j\omega) \overset{\mathrm{TR}}{\longmapsto} V_0^{\mathrm{TR}}(j\omega): \quad V_0^{\mathrm{TR}}(j\omega) = \left[V_0^{\mathrm{DT}}(j\omega)\right]^* \ . \ (3)$$

iii) The voltage along the line resulting from the injection of (3) at the line left end (see Fig. 1c) in the reversed time, reading $V^{\rm RT}(x,j\omega)$ in (4).

Next, to relate the above-formulated quantities, we first define the direct-time transfer function as the ratio of $V_0^{\mathrm{DT}}(j\omega)$ to $V_f(j\omega)$ according to (2), namely

$$\mathcal{H}^{\mathrm{DT}}(j\omega) = V_{0}^{\mathrm{DT}}(j\omega)/V_{f}(j\omega). \tag{5}$$

We define in a similar way the reversed-time transfer function

$$\mathcal{H}^{\rm RT}(x,j\omega) = V^{\rm RT}(x,j\omega)/V_0^{\rm TR}(j\omega). \tag{6}$$

It is important to underline that $V_{\scriptscriptstyle 0}^{\mathrm{DT}}(j\omega)$, which is obtained in the direct time, is time reversed and then behaves as an excitation in the reversed time. As a result, we can write

$$V^{\mathrm{RT}}(x, j\omega) = \mathcal{H}^{\mathrm{RT}}(x, j\omega) \cdot \left[\mathcal{H}^{\mathrm{DT}}(j\omega)\right]^* \cdot \left[V_f(j\omega)\right]^*$$
. (7)

Finally, we define the direct-reversed-time transfer function as

$$\mathcal{H}(x, j\omega) = \mathcal{H}^{\mathrm{RT}}(x, j\omega) \cdot \left[\mathcal{H}^{\mathrm{DT}}(j\omega)\right]^*,$$
 (8)

since it relates the output in the reversed time to the direct-time input. From (4) to (8), $\mathcal{H}(x, j\omega)$ can be analytically expressed as (9).

This way, the general task of locating faults along a transmission line can be accomplished by investigating the behavior of the direct-reversed-time transfer function only.

A. Theorem: mirrored minimum squared modulus of $\mathcal{H}(x, j\omega)$

The direct-reversed-time transfer function based on EMTR in lumped mismatched media presents a characteristics stated by the theorem as follows:

Theorem 1:
$$\forall f_h \in \mathbb{F}^{DT}$$
. $Min \left\{ |\mathcal{H}(x, j\omega)|^2 \right\} =$

$$\forall f_h \in \mathbb{F}^{\mathrm{DT}}, \min_{0 < x < L} \left\{ \left| \mathcal{H}(x, j\omega) \right|^2 \Big|_{\omega = 2\pi \cdot f_h} \right\} = L - x_f,$$

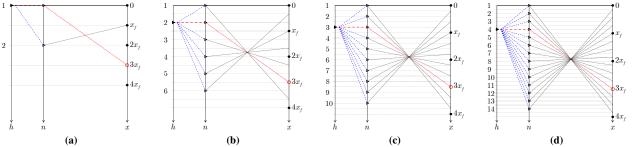


Fig. 2: Mapping among h, n and x of the fault case $x_f/L = 1/4$ for: (a) h = 1, $f = f^0$, $N_n = 2$; (b) h = 2, $f = 3f^0$, $N_n = 6$; (c) h = 3, $f = 5f^0$, $N_n = 10$, and (d) h = 4, $f = 7f^0$, $N_n = 14$.

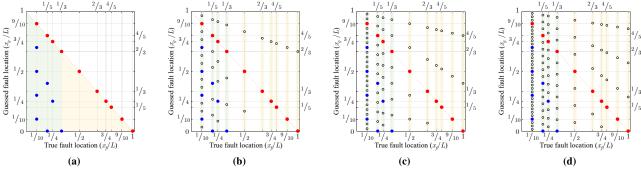


Fig. 3: Distribution of the local minima of $|\mathcal{H}_{d,h}(x)|^2$ for the fault cases of (18) at (a) h=1, $f=f^0$; (b) h=2, $f=3f^0$; (c) h=3, $f=5f^0$, and (d) h=4, $f=7f^0$. Among the dots, which represent the local minima, the red dots are the mirror-image points of the respective true fault locations. In addition, for the fault case where $x_f \in (0, L/3]$ the blue dots further indicate the locations of (20) that feature the local minimum of $|\mathcal{H}_{d,h}(x)|^2$ for each f_h .

where

$$\mathbb{F}^{DT} = \left\{ f_h \mid f_h = (2h - 1) \cdot f^0(x_f), \\ f^0(x_f) = 1/(4\Gamma_{x_f}), h = 1, 2, 3, \dots \right\}$$
 (10)

contains the fault inherent switching frequency $f^0(x_f)$ and its odd harmonics. Γ_{x_f} is the line one-way time delay of fault-originated traveling waves [34]. Unless otherwise emphasized, in what follows $f^0(x_f)$ will be concisely expressed as f^0 .

Theorem 1 states that, at each single frequency among \mathbb{F}^{DT} , the squared modulus of $\mathcal{H}(x,j\omega)$ reaches its minimum always at the mirror-image point (denoted by $x_{mir} = L - x_f$) of the true fault location x_f , with respect to the line center.

Proof. The squared modulus of $\mathcal{H}(x, j\omega)$ is calculated as in (11) according to the low-loss line approximation¹.

Obviously, only the term $|\mathcal{H}_d(x, j\omega)|^2$ in (11) is a function of the coordinate x, which directs the attention of the proof to discussing the behavior of $|\mathcal{H}_d(x, j\omega)|^2$ at those frequencies of \mathbb{F}^{DT} . There exists

$$|\mathcal{H}_d(x,j\omega)|^2 = e^{-\alpha \cdot 2x} + (\rho_L^v)^2 \cdot e^{-\alpha \cdot 2(2L-x)} + 2\rho_L^v \cdot e^{-\alpha \cdot 2L} \cdot \cos[\beta \cdot 2(L-x)], \tag{12}$$

 1 The electromagnetic transients originated by faults in power systems are generally characterized by a frequency spectrum dominating across the frequencies ranging from some kilohertz, in which the low-loss approximation in the transmission-line theory is justified for typical overhead lines and underground cables, namely $r\ll\omega\cdot l$ and $g\ll\omega\cdot c$. Given this, the characteristic impedance Z_C is independent of frequency and essentially the same as for a lossless line [41], meanwhile, the attenuation and phase constants respectively appear to be $\alpha\cong(r/Z_C+g\cdot Z_C)$ /2 and $\beta\cong\omega\cdot\sqrt{l\cdot c}$.

and, at $\forall f_h \in \mathbb{F}^{\mathrm{DT}}, \left|\mathcal{H}_{d,h}(x)\right|^2$ is defined by

$$|\mathcal{H}_d(x, j\omega)|^2 \Big|_{\omega=2\pi \cdot f_h} = e^{-\alpha \cdot 2x} + (\rho_L^v)^2 \cdot e^{-\alpha \cdot 2(2L-x)} + 2\rho_L^v \cdot e^{-\alpha \cdot 2L} \cdot \cos\left[(2h-1) \cdot \pi \cdot (L-x)/x_f\right].$$
(13)

The local minima of $|\mathcal{H}_{d,h}(x)|^2$ is, to a first approximation², determined by the *cos* term in (13) when

$$(2h-1) \cdot \pi \cdot (L-x)/x_f = (2n-1) \cdot \pi,$$

 $h=1,\,2,\,3,\,\ldots\,$, and $n=0,\,\pm 1,\,\pm 2,\,\pm 3,\,\ldots\,$. (14)

Thus, $|\mathcal{H}_{d,h}(x)|^2$ reaches its local minima at

$$x = L - (2n - 1)/(2h - 1) \cdot x_f. \tag{15}$$

Since $0 < L - x_f$, $x_f < L$, there exist two constraints on the values of h and n. First,

$$h = 1, 2, 3, ..., N_h$$
 with $N_h = \lfloor f_{max}/f^0 \rfloor$, (16)

where $\lfloor \cdot \rfloor$ denotes the floor function and f_{max} refers to the maximum of the frequency of interest. And for a given h,

$$n = 1, 2, 3, \dots, N_n$$
 with $N_n = | [(2h-1) \cdot (L/x_f) + 1]/2 |$.

Without limiting h to a finite number, the foregoing fact applies to $|\mathcal{H}_d(x,j\omega)|^2$ at \mathbb{F}^{DT} , thus proving *Theorem 1*. \square

 $^2 \text{The extrema of } \left| \mathcal{H}_{d,h}(x) \right|^2$ are determined by the third term of (13) because of the constant coefficient $2\rho_L^v$. Meanwhile, the third term approximates a periodic function of x since the monotonicity of $e^{-\alpha \cdot 2L}$ is not dominant, considering that L is in the order of tens to hundreds of kilometers in power grids.

We introduce here a case study and use lattice diagrams to illustrate (15). For example, it is assumed $x_f/L=1/4$. We consider the frequencies including f^0 and its odd harmonics up to the 7^{th} order in such a way that $h \leq (N_h=4)$. Figs. 2a to 2d, show the mapping, among h, n and x, governed by (15). It can be observed that, along the x-axis, the number as well as the locations of the local minima of $|\mathcal{H}_{d,h}(x)|^2$ differ in accordance with the value of h. As highlighted by the red lines in each of the diagrams, the mapping between h and n=h, resulting in the mirror-image point $x=x_{mir}=3x_f$ as a particular case being the location characterized by the local minimum of $|\mathcal{H}_{d,h}(x)|^2$ for each of the considered frequencies.

To be more general, the distribution of the local minima of $|\mathcal{H}_{d,h}(x)|^2$ for an arbitrary fault occurrence is shown in Fig. 3. The considered fault cases are characterized by

$$x_f/L = \{ {}^{1}/10, {}^{1}/5, {}^{1}/4, {}^{1}/3, {}^{1}/2, {}^{2}/3, {}^{3}/4, {}^{4}/5, {}^{9}/10, 1 \}.$$
(18)

Figures 3a to 3d illustrate respectively those distributions at f^0 and its odd harmonics up to the 7^{th} order. In agreement with *Theorem 1*, the red dots, which appear along the downward diagonal, demonstrate that the mirror-image point is always a local minimum of $|\mathcal{H}_{d,h}(x)|^2$ at each f_h and for each x_f .

B. Corollary 1: mirrored minimum energy of $\mathcal{H}(x, j\omega)$

The transfer function constitutes the frequency-domain representation to the impulse response of a linear time invariant system. According to Parseval's theorem, we calculate the energy of the impulse response of the direct-reversed-time system at \mathbb{F}^{DT} as follows:

$$E\left\{\left.\mathcal{H}(x,j\omega)\right|_{\mathbb{F}^{\mathrm{DT}}}\right\} \triangleq \sum_{h=1}^{N_h} \left\{\left.\left|\mathcal{H}(x,j\omega)\right|^2\right|_{\omega=2\pi \cdot f_h}\right\}. \quad (19)$$

There exists

Corollary 1:
$$\underset{0 < x < L}{Min} \left\{ E \left\{ \mathcal{H}(x, j\omega)|_{\mathbb{F}^{\mathrm{DT}}} \right\} \right\} = L - x_f.$$

Proof. To prove Corollary 1, we further define the set $x_{\mathbb{M}}$

Proof. To prove Corollary 1, we further define the set $x_{\mathbb{M}}$ of locations at which the local minimum of $|\mathcal{H}_{d,h}(x)|^2$ can be obtained at each f_h . For a given fault occurrence at $x = x_f$, $x_{\mathbb{M}}$ reads

$$\{ x_m | x_m = (L - x_f) - m \cdot 2x_f, m = 0, 1, 2, \dots, N_m \}.$$
(20)

For $x_f \in (L/3, L]$, $x_{\mathbb{M}}$ contains the mirror-image point as a single element (see the red dots in Fig. 3) while multiple local-minimum points exist for $x_f \in (0, L/3]$ (see also the additional blue dots in Fig. 3). At those locations x_m ,

$$|\mathcal{H}_{d,h}(x_m)|^2 = e^{-\alpha \cdot 2x_m} \cdot \left[1 - \rho_L^v \cdot e^{-\alpha \cdot 2(L - x_m)}\right]^2.$$
 (21)

Moreover, it can be found that $|\mathcal{H}_{d,h}(x_m)|^2$ monotonically decreases as x_m increases.

To sum up, *Corollary 1* is deduced from the properties as follows:

- i) Among those locations determined by (15) to (17), $x_m \in x_{\mathbb{M}}$ allows $|\mathcal{H}(x, j\omega)|^2$ to reach its local minimum at each f_h .
- ii) Among $x_{\mathbb{M}}$, the mirror-image point $x_m = x_{mir} = L x_f$ allows $|\mathcal{H}(x, j\omega)|^2$ to reach its global minimum at each f_h .
- iii) At the fault switching frequency f^0 , the cos term of $|\mathcal{H}_{d,h}(x)|^2$ in (13) reaches its last local minimum at x_{mir} .

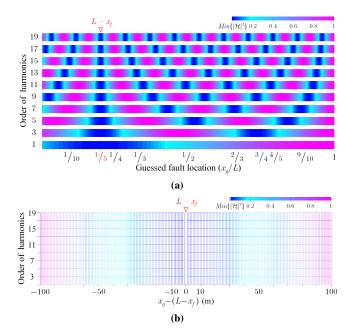


Fig. 4: Normalized squared modulus of $H(x_g, j\omega)$ calculated at f^0 (= 4.61 kHz) and its odd harmonics up to the 19^{th} order for the fault case: L=21 km and $x_f=16.8$ km. The guessed fault locations are defined: (a) every 10 m along the line and (b) every 1 m in the spacing between $(L-x_f)\pm 100$ m.

The mirror-image point x_{mir} is uniquely a local minimum of $|\mathcal{H}(x, j\omega)|^2$ at each $f_h \in \mathbb{F}^{DT}$, and thereby leading to the operation (19) at x_{mir} , namely the summation of those minimal over \mathbb{F}^{DT} , logically being the global minimum. \square

C. Numerical validation

In this subsection, we numerically illustrate the properties of the direct-reversed-time transfer function $\mathcal{H}(x,j\omega)$, which are stated by *Theorem 1* and *Corollary 1*. We consider a 21-km-long 66-kV single-phase overhead line simulated using the EMTP-RV built-in line parameters. Various fault cases are simulated at the locations given by (18).

Exemplified by the case of $x_f/L = 4/5$, we first observe in Fig. 4a the squared modulus of $\mathcal{H}(x, j\omega)$, which is distributed as a function of the guessed fault location x_q together with the order of the harmonics 2h-1. For assigning the values of x_q , L (= 21 km) is discretized by an increment step Δx of 10 m. As to f_h , we consider the maximum value of h as 10 to include f^0 and its odd harmonics up to the $19^{\text{-th}}$ order. For the sake of comparison, at a given harmonic f_h , the squared modulus of $\mathcal{H}(x, j\omega)$ is processed as³ $Map_{[0,1]}\{|\mathcal{H}_h(x_g)|^2\}$. As it can be seen, the normalized squared modulus reaches its minima at the locations satisfying the mapping relation of (15). Even though, in agreement with *Theorem 1*, the mirrorimage point $x_q/L = 1/5$ is indicated at each harmonic by the color signifying the minimal squared modulus. Fig. 4b reports a finer examination of the behavior of $|\mathcal{H}_h(x_q)|^2$ at the locations adjacent to the mirror-image point. To this end, the increment step Δx is reduced to 1 m to define the guessed fault locations in the spacing between $(L-x_f)\pm 100$ m. As a result, it confirms that, on a one-meter scale, the mirror-image point

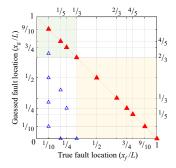
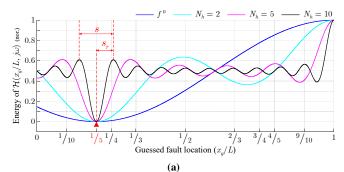


Fig. 5: Distribution of the global minima of $E\{\mathcal{H}(x_g,j\omega)|_{\mathbb{F}^{DT}}\}$ (denoted by the red triangles). For the cases of $x_f/L \in (0,1/3]$, there exist additional local minimum energy points that is related to the contribution of the f^0 -component of $|\mathcal{H}_h(x_g)|^2$. Those locations are shown by the blue triangles.



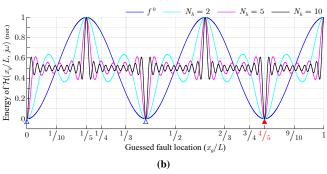


Fig. 6: Energy of $Map_{[0,1]}\left\{|\mathcal{H}_h(x_g)|^2\right\}$ calculated at f^{0} and its odd harmonics up to the 3^{rd} , 9^{th} , and 19^{th} order for the fault cases: (a) $x_f/L=4/5$ and (b) $x_f/L=1/5$. The guessed fault locations are defined by $\Delta x=1$ m. The normalization brings about that the calculated maximum energy appears to be the unit value.

uniquely features Theorem 1.

We proceed to present in Fig. 5 the validation of the mirrored minimum energy property of $\mathcal{H}(x,j\omega)$ formulated by Corollary I. $E\{\mathcal{H}(x_g,j\omega)|_{\mathbb{F}^{\mathrm{DT}}}\}$ of (19) is calculated by considering the upper-limit frequency in \mathbb{F}^{DT} as the 19^{th} order harmonic of f^{o} . The guessed fault locations are defined with Δx being 1 m. The global minima of $E\{\mathcal{H}(x_g,j\omega)|_{\mathbb{F}^{\mathrm{DT}}}\}$ in the respective cases are represented in Fig. 5 by red triangles. By observing that the red triangles are distributed along the downward diagonal, Corollary I is thus verified, indicating that the energies reach the minimum values exactly at the corresponding mirror-image points each.

To provide a detailed analysis, $|\mathcal{H}_h(x_q)|^2$ is normalized by

using the function $Map_{[0,1]}\{\mathbb{U}\}$. Fig. 6 depicts the curves of summating $Map_{[0,1]}\{|\mathcal{H}_h(x_g)|^2\}$ for f_h up to the 3^{rd} , 9^{th} , and 19^{th} order harmonic, respectively. The fault cases $x_f/L=4/5$ and 1/5 are here considered as examples.

Summing up the illustrations of Figs. 5 and 6, the following conclusions can be drawn.

- i) Although the calculation adopts different numbers of the harmonics, the normalized energy of $Map_{[0,1]}\left\{|\mathcal{H}_h(x_g)|^2\right\}$ reaches its global minimum always at the mirror-image point x_{mir} in all three scenarios (see the red triangle in Fig. 6).
- ii) For the cases of $x_f/L \in (0, 1/3]$, beyond x_{mir} , the f° -component of $Map_{[0,1]}\left\{|\mathcal{H}_h(x_g)|^2\right\}$ shows additional local minima at those locations where $E\left\{\mathcal{H}(x_g,j\omega)|_{\mathbb{F}^{\mathrm{DT}}}\right\}$ reaches its local minima as well (see the blue triangles in Figs. 5 and 6b).
- iii) The $f^{\scriptscriptstyle 0}$ -component of $Map_{[0,1]}\left\{|\mathcal{H}_h(x_g)|^2\right\}$ determines the location where $E\left\{\mathcal{H}(x_g,j\omega)|_{\mathbb{F}^{\rm DT}}\right\}$ shows its local or global minimum. The higher-frequency components, by comparison, contribute to an enhanced resolution in terms of distinguishing x_{mir} from its adjacent points. For instance, in the case of Fig. 6a, the focal-spot radius 4S_r is reduced from 6151 m to 1202 m if the upper-limit frequency in $\mathbb{F}^{\rm DT}$ is increased from $3f^0$ to $19f^0$.

III. FAULT LOCATION USING THE MIRRORED MINIMUM ENERGY PROPERTY OF THE REVERSED-TIME VOLTAGE

Compared to the transfer function $\mathcal{H}(x,j\omega)$, $V^{\mathrm{RT}}(x,j\omega)$ is a more direct quantity to be observed in the reversed time. This section discusses the properties of $V^{\mathrm{RT}}(x,j\omega)$ that enable identifying the true fault location.

A. Corollary 2: mirrored minimum energy of $V^{RT}(x, j\omega)$

The energy of the reversed-time voltage $V^{\rm RT}(x,\,j\omega)$ calculated at $\mathbb{F}^{\rm DT}$ is defined as follows

$$E\left\{ \left. V^{\mathrm{RT}}(x,j\omega) \right|_{\mathbb{F}^{\mathrm{DT}}} \right\} \triangleq \sum_{h=1}^{N_h} \left\{ \left. \left| V^{\mathrm{RT}}(x,j\omega) \right|^2 \right|_{\omega=2\pi \cdot f_h} \right\}. \tag{22}$$

There exists

Corollary 2:
$$\underset{0 < x < L}{Min} \left\{ E \left\{ V^{\text{RT}}(x, j\omega) \middle|_{\mathbb{F}^{\text{DT}}} \right\} \right\} = L - x_f.$$

It can be found in (2) and (4) that the excitation of $V_f(j\omega)$ at each f_h is a constant (i.e., independent of the coordinate x) and, as such, it is directly inferred from $Corollary\ I$ that $V^{\rm RT}(x,j\omega)$ equally features such a mirrored minimum energy property.

In this way, the fault location can be identified by its mirrorimage point through

$$x_f = L - \min_{0 < x < L} \left\{ E \left\{ V^{\text{RT}}(x, j\omega) \big|_{\mathbb{F}^{\text{DT}}} \right\} \right\}. \tag{23}$$

⁴Following the approach of assessing the refocusing quality of time-reversed waves to the source point, the concept of focal spot S is introduced by defining its radius S_r as the distance between x_{mir} and the extremum point that is closest to x_{mir} (see Fig. 6a).

 $^{^3}Map_{[0,1]}\{\mathbb{U}\}$ is a defined normalization function that maps a series of scalars \mathbb{U} into a closed set [0,1], showing $Max\{\mathbb{U}\}=1$ and $Min\{\mathbb{U}\}=0$.

$$E\left\{V^{\mathrm{RT}}(x,j\omega)\big|_{\mathbb{F}}\right\} = \sum_{k=1}^{N_k} \left\{ \left[\left| \tilde{V}_0^{\mathrm{DT}}(j\omega) \right|^2 \cdot Map_{[0,1]} \left\{ \left| \mathcal{H}^{\mathrm{RT}}(x,j\omega) \right|^2 \right\} \right] \bigg|_{\omega = 2\pi \cdot f_k} \right\}. \tag{25}$$

B. Proposed acceleration algorithm for calculating the energy of the reversed-time voltage

In this subsection, we propose an efficient algorithm to calculate the reversed-time voltage energy (22) and apply the mirror-image property (23) to identify the fault location.

From a practical point of view, the fault-originated transient voltage $V_0^{\rm DT}(t)$ is transformed into the frequency domain as $V_0^{\rm DT}(j\omega)$, allowing calculating the reversed-time voltage energy (22) in the frequency domain by

$$\sum_{h=1}^{N_h} \left\{ \left[\left| \tilde{V}_0^{\text{DT}}(j\omega) \right|^2 \cdot \left| \mathcal{H}^{\text{RT}}(x,j\omega) \right|^2 \right] \Big|_{\omega = 2\pi \cdot f_h} \right\}, \quad (24)$$

where $\tilde{V}_0^{\mathrm{DT}}(j\omega)$ denotes the fault-generated high-frequency transients, resulting from filtering out low-frequency steady-state components (e.g., of 50 Hz) from $V_0^{\mathrm{DT}}(t)$.

With the purpose of optimizing the performance of (24) in terms of fault location accuracy and computation efficiency, along with implementing the calculation of (24) through a data-driven strategy, the following considerations are in order.

- i) The normalization operation $Map_{[0,1]}\left\{|\mathcal{H}_h(x_g)|^2\right\}$ offsets the difference in magnitude between the components of $|\mathcal{H}(x,j\omega)|^2$ at \mathbb{F}^{DT} , thus maximizing the effect of the higher-frequency components to enable an enhanced resolution of localizing the fault location. It is proved that the local maxima of $|\mathcal{H}^{\mathrm{DT}}(x,j\omega)|$ appearing at \mathbb{F}^{DT} are equal to each other [34]. The operation $Map_{[0,1]}\left\{|\mathcal{H}_h(x_g)|^2\right\}$, therefore, can be equivalently achieved through normalizing $|\mathcal{H}^{\mathrm{RT}}(x,j\omega)|^2$.
- ii) Resulting from the Fourier transform, $\tilde{V}_0^{\mathrm{DT}}(j\omega)$ is distributed over $\mathbb{F} = \left\{0,\,\Delta f,\,\dots,\,f^{\mathrm{Ny}} \Delta f,\,f^{\mathrm{Ny}}\right\}$, in which Δf is determined by the number of sampling points of $V_0^{\mathrm{DT}}(t)$ and the Nyquist frequency f^{Ny} in accordance with a given sampling rate. Corollary 2 indeed applies to the frequencies belonging to \mathbb{F}^{DT} . Taking advantage of the fact that $\tilde{V}_0^{\mathrm{DT}}(j\omega)$ is dominated by its components at \mathbb{F}^{DT} (e.g., [34]), the voltage energy in (24) can be alternatively evaluated over \mathbb{F} and, thus, avoiding a dedicated extraction of \mathbb{F}^{DT} from \mathbb{F} .
- iii) As analyzed earlier, *Theorem 1* and its two corollaries do not rely on the components of $\mathcal{H}^{\mathrm{RT}}(x,j\omega)$ that are present at the frequencies below the fault switching frequency f^{0} . Given a set of guessed fault locations $x_{\mathbb{G}}=\left\{0,\Delta x,\ldots,L\right\}$, their fault switching frequencies satisfy $f^{0}(L)<\ldots< f^{0}(\Delta x)< f^{0}(0)$ [34], hence it is feasible to truncate \mathbb{F} by neglecting those frequencies belonging to $[0,f^{0}(L))$. A narrower frequency band avails a reduced computational time.

Given the above, the formula (24) calculating the energy of the reversed-time voltage can be modified as in (25), in which $\mathbb F$ is defined as

$$\mathbb{F} = \left\{ f_k | f_k = f^0(L) + k \cdot \Delta f, \ k = 0, 1, 2, \dots, N_k \right\}$$
with $N_k = \lfloor [f^{\text{Ny}} - f^0(L)] / \Delta f \rfloor$.
(26)

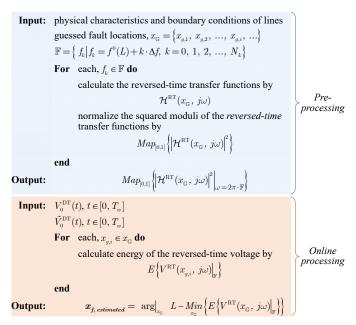


Fig. 7: Pseudo-algorithm for calculating the fault location metric of the reversed-time voltage energy.

To sum up, the step-by-step processing of computing (25) to address the fault location problem is summarized as a pseudo-algorithm presented in Fig. 7.

The algorithm starts by employing the parameters of the targeted transmission line to construct a database or dictionary, which indexes over the normalized reversed-time transfer functions $Map_{[0,1]}\left\{|\mathcal{H}^{\mathrm{RT}}(x,j\omega)|^2\right\}$ of a set of guessed fault locations $x_{\mathbb{G}}$ and frequencies \mathbb{F} . As indicated as pre-processing, this procedure can be carried out prior to a fault event since it is not subject to any fault-case-dependent knowledge. Specifically, $x_{\mathbb{G}}$ is a priori assumed in line with a user-desired fault-location accuracy. Also, in practice, f^{Ny} and Δf are explicit, depending on the adopted measurement capabilities (e.g., samling rates) and pre-settings (e.g., the length of the time window T_w for recording $V_0^{\mathrm{DT}}(t)$). Thus, \mathbb{F} is also known.

In the fault location stage, the traditional EMTR routine consists in back-injecting a time-reversed copy of $V_0^{\mathrm{DT}}(t)$ to simulate offline the backward propagation. In contrast, by employing such a data-driven strategy to pool the normalized reversed-time transfer functions beforehand, the fault location task can be accomplished quasi-instantaneously after having acquired $V_0^{\mathrm{DT}}(t)$.

C. Sensitivity analysis with respect to uncertainties

In this subsection, the proposed fault location metric of the reversed-time voltage energy (25) is examined by implementing the algorithm of Fig. 7 to cope with different fault cases, which are simulated involving the variation in i) line parameter and length, ii) fault location, and iii) fault inception, and iv) fault impedance. Moreover, the influence of noise in measurements is assessed.

TABLE II: Fault location error of the metric (25) for the cases involving different line parameters, lengths, fault locations, and fault inception angles. The values in parentheses correspond to a fault inception angle of 2 degrees.

	Fault location error (%e)					
x_f/L	21 km (66 kV)	45 km (220 kV)	75 km (345 kV)	120 km (500 kV)		
1/10	0.00 (0.00)	0.00	0.00	0.00 (0.00)		
1/5	$0.00 \ (\overline{0.10})$	0.00	0.00	0.00 (0.00)		
1/4	0.00 (0.00)	0.00	0.00	0.00 (0.00)		
1/3	$\overline{0.03}$ (0.03)	$\overline{0.03}$	$\overline{0.03}$	$\overline{0.03}$ $(\overline{0.03})$		
1/2	0.00 (0.00)	0.00	0.00	0.00 (0.00)		
2/3	0.03 (0.03)	0.03	0.03	0.03 (0.03)		
3/4	0.00 (0.00)	0.00	0.00	0.00 (0.00)		
4/5	0.00 (0.00)	0.00	0.00	0.00 (0.00)		
9/10	0.00 (0.00)	0.00	0.00	0.00 (0.00)		
1	0.00 (0.00)	0.00	0.00	0.00 (0.00)		

The simulations were carried out in the EMTP-RV environment, configuring various line set-ups with the built-in AC-66/220/345/500-kV constant-parameter (CP) single-phase overhead lines, and assuming a ground resistivity of $100~\Omega$ -m. As presented in Table II, the line length was varied from $21~\rm km$ to $120~\rm km$ as the rated voltage increases. For each line set-up, a single-phase-to-ground fault was simulated at the locations given by (18), one after another. A 40-ms time window (i.e., $T_w=40~\rm ms$, twice the circle duration of the 50-Hz steady-state voltage) was used to rerecord the fault-originated transient voltage $V_0^{\rm DT}(t)$ at the line end, which was grounded via $100{\rm -k}\Omega$ impedance. The sampling rate was set at $20~\rm MS/s$.

According to the above settings, the pre-processing reserves an array of the normalized reversed-time transfer functions that vary in the frequencies \mathbb{F} , with Δf being 190.73 Hz, and the guessed fault locations $x_{\mathbb{G}}$. The lower limit of \mathbb{F} is determined as a function of the line length L. The frequencies of $f^0(L)$ were thus determined, according to (10), as 3.57, 1.66, 0.99, and 0.62 kHz corresponding to the considered line lengths L of 21, 45, 75, and 120 km, respectively. Meanwhile, $x_{\mathbb{G}}$ was defined by specifying $\Delta x = L \times 10^{-4}$, for example, $\Delta x = 2.1$ m for the 66-kV line set-up.

After simulating each fault event, $V_0^{\rm DT}(t)$ was processed by a $4^{\rm th}$ order Butterworth high-pass filter with a cut-off frequency of 500 Hz, yielding the high-frequency transients $\tilde{V}_0^{\rm DT}(t)$. Its frequency-domain counterpart $\tilde{V}_0^{\rm DT}(j\omega)$, together with the built-up reversed-time transfer functions, finalized the calculation of the metric (25), providing an estimation for the most-likely fault location.

Table II presents the fault location accuracy of the metric (25) for the considered cases involving different line parameters, lengths, as well as fault locations. The upper-bound fault location error⁵ in each column is indicated in bold type and with an overline. As it can be noticed, the metric (25) identifies the exact true fault location in most cases. In the few remaining cases, the errors are insignificant (a maximum of 0.03 ‰).

In order to evaluate the impact of the fault inception angle (θ_f) , the simulation also involves near zero-crossing cases, in which θ_f is extremely small. For the sake of comparison, Table II includes the resultant error (in parentheses) in locating faults

TABLE III: Fault location error of the metric (25) for the cases involving different line parameters, lengths, fault locations, and fault impedance.

		F	ault locat	t location error (%o)			
$R_f(\Omega)$	10	30	60	10	30	60	
L x_f/L	21 km 120 km (66 kV) (500 kV)	
1/10	0.00	0.00	0.00	0.00	0.00	0.00	
1/5	0.00	0.00	0.00	0.00	0.00	0.00	
1/4	0.00	0.00	$\overline{0.10}$	0.00	0.00	0.00	
1/3	$\overline{0.03}$	$\overline{0.03}$	0.07	$\overline{0.03}$	$\overline{0.03}$	$\overline{0.03}$	
1/2	0.00	0.00	0.00	0.00	0.00	0.00	
2/3	0.03	0.03	0.03	0.03	0.03	0.03	
3/4	0.00	0.00	0.10	0.00	0.00	0.00	
4/5	0.00	0.00	0.10	0.00	0.00	0.00	
9/10	0.00	0.00	0.10	0.00	0.00	0.00	
1	0.00	0.00	0.00	0.00	0.00	0.00	

TABLE IV: Fault location error of the metric (25) for the cases involving different line parameters, lengths, fault locations, and measurement noise.

	Fault location error (%e)						
SNR (dB)	40	20	10	40	20	10	
L x_f/L		21 km (66 kV)		120 km (500 kV)			
1/10	0.00	0.00	0.40	0.00	0.00	0.20	
1/5	0.00	0.20	0.30	0.00	0.00	0.10	
1/4	0.00	0.20	0.20	0.00	0.00	0.00	
1/3	$\overline{0.03}$	0.03	0.13	$\overline{0.03}$	$\overline{0.07}$	$\overline{0.23}$	
1/2	0.00	0.20	0.10	0.00	0.00	0.10	
2/3	0.03	0.07	0.27	0.03	0.03	0.07	
3/4	0.00	0.00	0.50	0.00	0.00	0.00	
4/5	0.00	0.10	0.10	0.00	0.00	0.10	
9/10	0.00	$\overline{0.30}$	0.20	0.00	0.00	0.10	
1	0.00	0.20	$\overline{1.00}$	0.00	0.00	0.10	

with θ_f being 2 degrees along the 66- and 500-kV line. It is confirmed that the metric provides an equal-level of accuracy to locate such faults.

The performance of the metric (25) was also assessed with reference to resistive faults by assuming the fault impedance (R_f) ranging from $10~\Omega$ to $60~\Omega$. Table III presents the fault location errors for the 66- and 500-kV line set-ups, considering different fault locations given by (18). It can be seen that the proposed metric features excellent location accuracy also for resistive faults.

Finally, the sensitivity of the metric (25) to noise was investigated. Table IV tabulates the fault location errors when applying Gaussian noise with different SNRs affecting the acquired voltage $V_0^{\rm DT}(t)$. As shown, among the results in the extreme envisaged situation with an SNR of 10 dB, the most degraded performance appears to be a fault location error of 1 ‰, corresponding to a deviation of 21 m.

In each of the above-mentioned cases, the metric (25) was calculated 10^4 times in accordance with a precision Δx of $L\times 10^{-4}$. With regard to the computation efficiency of the acceleration algorithm, the simulation study involves a total of 320 cases, consuming an average of 127.82-s CPU time to accomplish the online processing by means of a conventional laboratory-level computational resource: Intel E5-1620 CPU @ 3.5 GHz, 16.0-GB RAM.

⁵Fault location error (‰) = $|x_f - x_{f,estimated}|/L \times 1000$.

IV. FAULT LOCATION PERFORMANCE ASSESSMENT OF THE MIRRORED MINIMUM ENERGY METRIC

In this section, the fault location performance of the mirrored minimum energy metric is further assessed with reference to other fault location metrics belonging to the category of traveling-wave-based methods. To be specific, the following three metrics are considered:

i) The classical single-end metric [1]

$$x_{f, estimated} = 0.5 \cdot (t_0^r - t_0) \cdot v. \tag{27}$$

ii) The classical two-end metric dependent on synchronized measurements [1]

$$x_{f, estimated} = 0.5 \cdot [L - (t_L - t_0) \cdot v] . \tag{28}$$

iii) The setting-free two-end metric eliminating the need for time synchronization [15]

$$x_{f, \text{ estimated}} = \frac{(t_0^r - t_0)}{(t_0^r - t_0) + (t_L^r - t_L)} \cdot L.$$
 (29)

The metrics (27)-(29) require detecting the time of arrival of fault-originated traveling waves. For the sake of explanation, Fig. 8 describes the time-space distribution of the initial and reflected traveling waves caused by a fault occurrence at $x=x_f$ along a transmission line of length L. The first incident traveling waves are assumed to arrive at the line ends x=0 and x=L at the instants t_0 and t_L , respectively. t_0^r and t_L^r denote the respective arrival instants of the traveling waves reflected for the first time from the fault location. Besides, v is the wave propagation velocity.

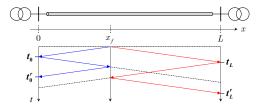


Fig. 8: Lattice-diagram illustration of fault-originated traveling waves being measured at two line terminals.

Three scenarios, which are typical in real-world applications and likely to incur fault location errors of traveling-wave-based methods, are simulated to compare the fault location performance of the proposed mirrored minimum energy metric with those of the three reference metrics.

Scenario 1: the fault-associated features are not prominent in the acquired traveling waves. For example, in the case of a slight fault inception angle and in the presence of certain fault impedance, the fault-originated traveling waves can be fast attenuated and also contaminated by background and quantization noise. This situation constitutes a common problem for the metrics under study, because it not only raises the challenge of detecting the arrival instants of the incident and reflected traveling waves but also superimposes considerable stray components onto the fault-originated transients' frequency spectrum.

In line with the above consideration, single-phase-to-ground fault events were simulated along the 120-km 500-kV line (see Section III-C) to take into account the effects of the foregoing

factors: the fault was characterized by a 2-degree fault inception angle and $30\text{-}\Omega$ fault impedance; the SNR was specified as 40~dB.

Scenario 2: in accordance with (23), (27)-(29), an inaccurate knowledge of the physical parameters v and L can be a source of fault location errors. In practice, prior to a transmission line being put into live operation, utilities generally conduct unenergized tests to infer the actual value of v. However, in spite of utilizing the Global Positioning System (GPS) to measure the overall length L, the manufacturing and engineering error can still exist, since the error appears to be at a relatively-small scale and, thus, is difficult to be effectively rectified. In this regard, a 1-% error ΔL was introduced in the study.

Scenario 3: the imprecision in time alignment causes fault location errors for metrics, which rely on calculating the difference between the instants of fault-originated traveling waves respectively arriving at the two line ends. In the study, the fault location performance given by (28) is additionally evaluated by assuming an error Δt_L in detecting t_L . By considering a typical accuracy of clock synchronization suggested by the IEEE standard [50], Δt_L was set to $10~\mu s$.

The continuous wavelet transform (CWT) coefficient of the fault-originated traveling waves was computed to detect the instants t_0 , t_0^r , t_L , and t_L^r [51], [52]. Daubechies4 wavelet was employed as the mother wavelet [53]. The mirrored minimum energy metric was calculated following the settings introduced in Section III-C.

Table V summarizes the fault location performance of the studied metrics dealing with the fault cases under the first scenario. The metrics present different magnitudes of fault location errors. As it can be seen, the classical single-end metric (27) is markedly impaired since it demands to identify both arrival instants t_0 and t_0^r accurately. A minor deviation from the actual t_0^r in detecting some weak reflections can result in manifest fault location errors. The setting-free metric (29) synthesizes the measurements at two line ends and mitigates, to a certain extent, the impact of erroneously recognizing t_0^r or/and t_L^r . The classical two-end metric (28), by comparison, only requires detecting the arrival instant of the first incident traveling waves and produces improved fault location performance. The mirrored minimum energy metric (25), on the other hand, is based on the full waveform of fault-originated traveling waves without requiring the detection of the set of arrival instants, as clarified in the previous sections. It is characterized by a maximum location error of 360 m (i.e., 3 %o).

Figure 9 presents the scatter distribution of the fault location error according to the results mentioned above. For a given fault event, the plots show the errors of the proposed metric and the reference metrics along the horizontal and vertical axes, respectively. The color-filled area in each plot indicates that the proposed metric achieves a higher level of accuracy compared to one of the reference metrics. As shown, the blue dots, which represent the first scenario, predominantly spread over the filled area, thus demonstrating the superior performance of the mirrored minimum energy metric.

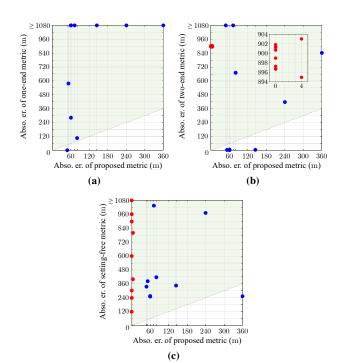
The red dots in Figs. 9b and 9c are related to the second scenario involving a 1-% deviation from the actual line length L, namely $\Delta L=1.2$ km. To focus on examining the influence

x_f/L Error	Single-end metric (27)		Two-end metric (28)		Setting-free metric (29)		Proposed metric (25)	
	Absolute (m)	Relative (‰)	Absolute (m)	Relative (‰)	Absolute (m)	Relative (‰)	Absolute (m)	Relative (%o)
1/10	282.24	2.369	2.28	0.019	254.97	2.125	60	0.5
1/5	1.14	0.009	1718.05	14.317	335.53	2.796	48	0.4
1/4	1396.39	11.637	1396.39	11.637	1035.38	8.628	72	0.6
1/3	577.71	4.814	4.05	0.034	382.89	3.19	52	0.433
1/2	1734.18	14.452	7.49	0.062	249.79	2.082	60	0.5
2/3	106.13	0.884	670.5	5.587	416.98	3.475	80	0.667
3/4	1649.41	13.745	417.39	3.478	972.37	8.103	240	2
4/5	1256.21	10.468	842.22	7.044	252.98	2.108	360	3
0/10	1666.25	13 885	5 22	0.043	345.06	2 875	144	1.2

0.039

4.65

TABLE V: Fault location error of the metrics (25), (27)-(29) for the cases along the 120-km 500-kV line. The simulated fault is characterized with a 2-degree fault inception angle and $30-\Omega$ fault impedance. A 40-dB SNR is assumed.



2999.79

1

24.998

Fig. 9: Scatter distribution of the absolute fault location error. The horizontal coordinate of each dot is the absolute error of the proposed metric (25). Its vertical coordinate is the absolute error in locating the corresponding fault occurrence using one of the reference metrics: (a) (27), (b) (28), and (c) (29). The blue dot represents the scenario where the fault-associated features do not dominate the acquired traveling waves. The red dot stands for the situation in which a deviation ΔL of 1 % from the actual line length L exists.

of ΔL , we refer to the solid fault events in Section III-C, ensuring that the set of arrival instants are correctly identified. It can be seen that the proposed metric is not affected by the considered uncertainty. In contrast, metrics (28) and (29) report the fault location errors up to 903.04 m (i.e., 7.525 ‰) and 1080.76 m (i.e., 9.006 ‰), respectively.

As analyzed previously, metric (28) enables pinpointing the fault location in some cases under the first scenario. However, compared to the other three metrics under study, its fault location performance can degrade due to incorrect time synchronization. For example, a deviation Δt_L of 10 μs from the actual t_L results in the fault location errors of the ten cases with an

average of 1499.28 m (i.e., 12.494 %o).

V. EXPERIMENTAL VALIDATION

60

0.5

In this section, we present an experimental validation of the energy of the reversed-time voltage as a fault location metric by means of a reduced-scale set-up, which made use of a 477-m-long standard RG-58 cable composed of two segments of 73 m and 404 m in length, respectively. At the two ends of the set-up, the inner conductor was connected to the shield with resistors $Z_0=560~\Omega$ and $Z_L=1~\mathrm{k}\Omega$. Note that the values of the resistances are relatively high in comparison with the 50- Ω characteristic impedance Z_C of the RG-58 cable. A DC voltage of 6 V supplied the set-up from the line end at x=0, which also served as the single observation point.

In the direct time, a solid fault was emulated by triggering a short circuit between the inner and shielding conductors of the cable. The fault was designed to occur at the junction of the two cable segments, namely $x_f=73\,\mathrm{m}$. For correctly producing the fault in such a reduced-scale set-up, the hardware fault emulator needs to feature a high-speed switch that is capable of changing its status in a few nanoseconds. To address this constraint, we adopted a metal-oxide semiconductor field-effect transistor (MOSFET) with a turn-on time of 3 ns [32]. The fault-induced response was measured as the voltage $V_0^{\mathrm{DT}}(t)$ across Z_0 . A 14-bit NI PCI-5122 digitizer was used to perform the measurement at a sampling rate of 100 MS/s.

In the reversed time, $\tilde{V}_0^{\mathrm{DT}}(j\omega)$ was extracted by retaining the frequency-domain components of $V_0^{\mathrm{DT}}(t)$ present above 500 Hz. The voltage energy metric (25) was calculated over the frequencies \mathbb{F} ranging from 103.76 kHz (i.e., $f^0(L=477)$) to 50 MHz. Fig. 10 depicts the curve of $E\left\{V^{\mathrm{RT}}(x_{\mathbb{G}},j\omega)\big|_{\mathbb{F}}\right\}$ as a function of the guessed fault location. $x_{\mathbb{G}}$ is defined along the cable with a discretization Δx of 1 m. The curve intersects with the red dash line that indicates the mirror-image point at the location $x_g=404$ m, which coincides exactly with the value of $L-x_f$ given that L=477 m and $x_f=73$ m.

The obtained results provide an experimental evidence of the metric (25) in terms of its validity, meanwhile showing its capability of attaining a better-than-1-m fault location accuracy. Moreover, the computation efficiency of the algorithm is highlighted by a 0.94-s consumption of the online processing.

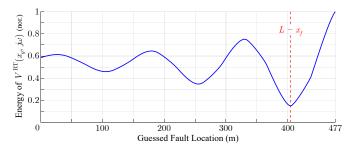


Fig. 10: Normalized energy of the reversed-time voltage as a function of the guessed fault location for the emulated fault at $x_f = 73$ m.

VI. DISCUSSION

The paper has provided an explicit definition, supported by a rigorous mathematical proof, of the mirrored minimum energy property of the EMTR in mismatched media. Recently, the property has been increasingly employed to develop a new branch of EMTR-based fault location methods. However, it is worth mentioning that there was a lack of rigorous investigation of the theoretical basis of this EMTR property and of the existing fault location metrics relying on it. In addition, a data-driven algorithm has been proposed, allowing the property to be utilized as a fault location metric with feasible computation efficiency and sufficient fault location accuracy.

Regarding the limitations, as clarified in Section I, EMTR-based fault location methods rely on the full waveform of fault -originated electromagnetic transients. Thus, from a practical viewpoint, the proposed metric requires measurement devices (e.g., high-voltage voltage transducers or current probes) featuring a sufficiently wide frequency bandwidth up to hundreds of kHz and above. Moreover, like other parameter-dependent traveling-wave methods, the fault location performance of the proposed metric is subject to inaccurate knowledge about the propagative parameters of targeted transmission lines. The line parameter errors need to be identified *a priori* and reduced to the largest degree through actual measurements or by taking advantage of parameter estimation techniques.

For the sake of analytically formulating the direct-reversedtime transfer function and deriving its modulus and energy characteristics versus the fault switching frequency and harmonics, the present study has considered a two-end transmission-line configuration. The existing metrics, either matched or mismatched media based (e.g., [32], [47]), have shown that EMTR fault location methods may apply to the traveling-wave propagation medium characterized by multiple scattering as a result of the branched topology of power networks. Given the above, future research should focus on extending the mirrored minimum energy metric to locate faults in complex branched power networks using single-end measurements. The presence of multi-branches causes the fault-switching-frequency component of $V_0^{\rm DT}(t)$ to mix with stray components, which are inherent to the complex topology of targeted transmission-line networks [11]. There are various approaches available in literature for identifying the fault-switching frequency in the frequency spectrum $V_0^{\mathrm{DT}}(j\omega)$. For example, the proposed metric can be coupled with the continuous-wavelet-based signal processing (i.e., [11], [54]) in view of its additional advantage of recognizing the faulty line branch.

Furthermore, optimal placement of the single observation point in complex branched power networks, with the aim of enabling the fault-switching-frequency component to dominate $V_0^{\mathrm{DT}}(j\omega)$, needs to be studied, given its large influence on the performance of EMTR-based fault location methods.

VII. CONCLUSIONS

In this paper, we presented a detailed study of the mirrored minimum energy property of EMTR in lumped mismatched media, with particular reference to the fault location problem in power systems.

Firstly, we formulated a direct-reversed-time transfer function that relates the fault source signal to the voltage along the line resulting from back-injecting the time-reversed fault-generated transients. Then, we presented a theorem, according to which, at the fault switching frequency and its odd harmonics, the mirror-image point of the fault location corresponds to a local minimum of the squared modulus of the transfer function. Next, the mirrored minimum energy property is proved to be a corollary of the main theorem.

Based on these theoretical findings, we proposed an algorithm that calculates the reversed-time voltage energy as a fault location metric in the frequency domain, instead of the original time-domain approach. We demonstrated that it is possible to enhance the computational efficiency of the fault location procedure by leveraging a data-driven strategy, consisting of precalculating an array of normalized reversed-time transfer functions over a set of guessed fault locations and a range of frequencies of interest. The applicability and robustness of the frequency-domain fault location metric were numerically and experimentally validated, respectively. The proposed metric has been benchmarked against representative fault location approaches belonging to traveling-wave-based methods, demonstrating its superior performance.

Note that the proposed data-driven algorithm has been verified to be capable of assessing the fault location online quasi-instantaneously after acquiring fault-originated transients and, thus, advancing EMTR-based fault location towards a real-time implementation.

As a topic of future studies, pilot tests are expected to be conducted to experimentally validate the proposed data-driven fault location algorithm based on EMTR in mismatched media with reference to real faults in power systems. Moreover, future research needs also lie in extending the mirrored minimum energy metric to locate faults in complex branched power networks using single-end measurements.

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